3.3. CLASSIFICATION AND USE OF POWDER DIFFRACTION DATA

```
Example 3.3.8.3. Identifying intensities from multiple detectors.

loop_
    _pd_meas_2theta_scan
    _pd_meas_intensity_total
    _pd_meas_detector_id
    5.0 10 A 25.0 16 B 45.0 23 C 65.0 18 D
    5.02 16 A 25.02 30 B ... ...
```

```
Example 3.3.8.4. Measurements from an energy-dispersive X-ray
  diffraction experiment.
_pd_meas_scan_method
                            disp
pd meas 2theta fixed
                            6.5
pd calib 2theta offset
                            0.1071
loop
  _pd_meas_detector id
  _pd_meas_counts total
  _pd_proc_energy_detection
  pd proc recip len Q
        180 6114.0 .714
        166
              6141.2 .717
          11
              6168.4 .721
          11
              6195.5 .724
```

In Example 3.3.8.3, four detectors placed 20° apart are referenced with arbitrarily chosen labels A, B, C and D. Note that the detector characteristics will typically be specified in a separate calibration loop containing terms such as _pd_calib_detector_id, _pd_calib_detector_response and _pd_calib_2theta_offset. The labels given for _pd_calib_detector_id should match those in pd meas detector id.

3.3.8.4. Energy-dispersive X-ray detection

For energy-dispersive X-ray diffraction, an X-ray detector is placed at a fixed value of 2θ and a diffractogram is measured on a multichannel analyser. The channel number is then calibrated to yield photon energies. From the energy and 2θ angle, a d-spacing or Q value ($Q=4\pi\sin\theta/\lambda$) is calculated for each diffraction point. Note that energy, d spacing or Q are not the experimental independent variable. Rather, they result from processing, since calibration information is required. The calibration equation should be described in pd calibration conversion eqn.

In Example 3.3.8.4, the nominal 2θ setting is 6.5° , but the actual position (determined by prior calibration) is 6.6071° , so the difference is indicated using a <code>pd_calib_2theta_offset</code> value (see Section 3.3.4.3).

3.3.8.5. Neutron time-of-flight detection

Neutron time-of-flight (TOF) detection in theory should be no different from energy-dispersive X-ray detection, but TOF instruments record complex three-dimensional data structures, where diffraction intensities are recorded as a function of time for as many as several hundred detectors. For some instruments, both the position along the detector and the time of flight are recorded, so there may be effectively thousands of detectors. To add even further complexity, the data may be binned in different time steps for detectors at different 2θ values. CIF is likely to be cumbersome for the storage of unprocessed measurements from TOF instruments, owing to the one-dimensional nature of CIF, but it could be useful to translate files from one binary format to another using CIF as a common intermediate. To do this, a single loop is used for all data points, where each detector (or detector section, in the case of a position-sensitive detector) is assigned a detector ID. In a second loop, the detector ID values are defined. In addition to

```
Example 3.3.8.5. Measurements from a neutron time-of-flight
  diffraction experiment.
pd meas scan method
                            tof
loop
 _pd_meas_detector id
 _pd_meas_time_of_flight
  pd_proc d spacing
 _pd_meas_counts_total
  pd proc intensity incident
      1101.6 0.251658559 11843
                                     4003
        1103.2
                0.25202477
                              11934
                                     4001
                                     3999
       1104.8
                0.252391011
                              11906
   88
    88
        1106.4
                0.252757192
                              11773
                                     3997
   88
        1108.0
                0.253123432
                              11707
                                     3995
   150 1500.0 0.257258087
                               6559
                                     3185
loop
 _pd_calib_detector id
 _pd_meas_2theta fixed
     88 88.05
     150 148.29
```

 2θ , _pd_meas_angle_omega and _pd_meas_angle_chi are defined where needed (Example 3.3.8.5).

TOF data are usually reduced to a small number of 'banks' consisting of intensity as a function of d space or Q, where multiple detectors are summed. Data in this form can be recorded using a loop containing <code>_pd_proc_d_spacing</code> and <code>_pd_proc_intensity</code> net. A data block is needed for each bank.

3.3.8.6. Digitized film and image plates

To record intensities from digitized X-ray film or from image plates properly requires the storing of two-dimensional data structures, which in some cases can be accommodated through imgCIF (see Chapters 2.3 and 3.7). However, it is possible to record a one-dimensional scan using <code>_pd_meas_position</code> and <code>_pd_meas_intensity_total</code> (not <code>_pd_meas_counts_total!</code>). <code>_pd_proc_2theta_corrected</code> values can then be assigned using calibration information, and they can then be included in the same loop, as in Section 3.3.8.4.

3.3.8.7. Direct background measurements

For some diffraction experiments, particularly for the determination of radial distribution functions, measurements are made for background scattering from the diffraction instrument and from the sample container. When this is done, the values can be included in a single loop using <code>_pd_meas_counts_background</code>, <code>_pd_meas_counts_container</code> and <code>_pd_meas_counts_total</code>.

3.3.8.8. Noting sample orientation

For texture measurements, intensity measurements can be made as a function of different sample setting angles. These setting angles can be specified using <code>_pd_meas_angle_chi</code>, <code>_pd_meas_angle_omega</code> and <code>_pd_meas_angle_phi</code>. The change in these values may be specified by including these data items in the loop with the diffraction intensities. In some cases, it may be more convenient to separate measurements with different setting angles into different blocks. In this case, the values for the setting angle(s) that are invariant will be set outside of a loop.

It is common in powder diffraction to reduce preferred orientation and improve crystallite averaging by rocking or rotating the sample. This is indicated by specifying the axis used for rocking, usually φ for capillary specimens or χ for flatplate specimens, as $pd_{meas_rocking_axis}$. The data item